

500V N-Channel MOSFET

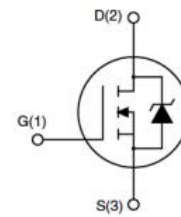
RCF18N50

General Description :

RCF18N50, N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-220F, which accords with the RoHS standard.

V_{DSS}	500	V
I_D	18	A
$P_D (T_C = 25^\circ\text{C})$	70	W
$R_{DS(ON), TYP.}$	0.28	Ω

TO-220F



Features:

- ▶ Fast Switching
- ▶ Low ON Resistance
- ▶ Low Gate Charge
- ▶ Low Reverse transfer capacitances
- ▶ 100% Single Pulse avalanche energy Test

Applications:

- ▶ Power switch circuit of adaptor and charger

Absolute ($T_C = 25^\circ\text{C}$ unless otherwise specified) :

Symbol	Parameter	Rating	Units
V_{DSS}	Drain -to -Source Voltage	500	V
I_D	Continuous Drain Current	18	A
I_{DM}^{a1}	Pulsed Drain Current	72	A
V_{GS}	Gate -to - Source Voltage	± 30	V
E_{AS}^{a2}	Single Pulse Avalanche Energy	1400	mJ
P_D	Power Dissipation	70	W
	Derating Factor above 25°C	0.56	W/ $^\circ\text{C}$
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150 , - 55 to 150	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

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Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction - to - Case	1.79	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction - to - Ambient	100	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics ($T_c = 25^{\circ}\text{C}$ unless otherwise specified) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	500	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D = 250\mu A, \text{Reference } 25^{\circ}\text{C}$	--	0.55	--	$\text{V}/^{\circ}\text{C}$
I_{DSS}	Drain to Source Leakage Current	$V_{DS} = 500V, V_{GS}=0V, T_a=25^{\circ}\text{C}$	--	--	1.0	μA
		$V_{DS}=400V, V_{GS}=0V, T_a=125^{\circ}\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS} = +30V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS} = -30V$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain -to -Source On - Resistance	$V_{GS} = 10V, I_D = 9A$	--	0.28	0.35	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	--	4.0	V
g_{fs}	Forward Trans conductance	$V_{DS} = 15V, I_D = 18A$	--	14	--	S
Pulse width < 380 μs ; duty cycle < 2%.						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ $f = 1.0\text{MHz}$	--	2430	--	pF
C_{oss}	Output Capacitance		--	236	--	
C_{rss}	Reverse Transfer Capacitance		--	25	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn -on Delay Time	$I_D = 18A, V_{DD} = 250V$ $V_{GS} = 10V, R_g = 6.1\Omega$	--	15	--	ns
t_r	Rise Time		--	30	--	
$t_{d(OFF)}$	Turn -Off Delay Time		--	50	--	
t_f	Fall Time		--	40	--	
Q_g	Total Gate Charge	$I_D = 18A, V_{DD} = 250V$ $V_{GS} = 10V$	--	52	--	nC
Q_{gs}	Gate to Source Charge		--	13	--	
Q_{gd}	Gate to Drain (" Miller ") Charge		--	20	--	

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Source- Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_{SD}	Continuous Source Current (Body Diode)		--	--	18	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	72	A
V_{SD}	Diode Forward Voltage	$I_S = 158A, V_{GS} = 0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_S = 18A, T_j = 25^\circ C$	--	592	--	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s, V_{GS} = 0V$	--	4.7	--	μC

a1 : Repetitive rating; pulse width limited by maximum junction temperature

a2 : $L=10mH$, $I_D = 18A$, Start $T_J = 25^\circ C$

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Characteristics Curves

Figure 1: Output Characteristics

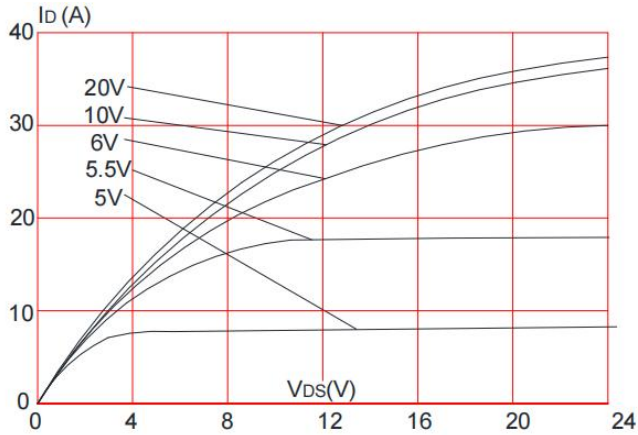


Figure 2: Typical Transfer Characteristics

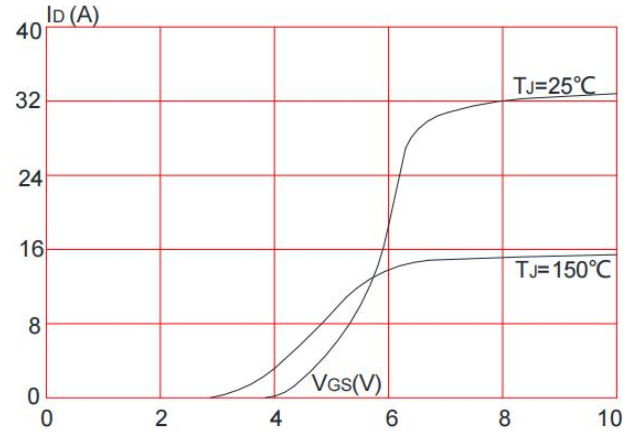


Figure 3: On Resistance Vs Drain Current

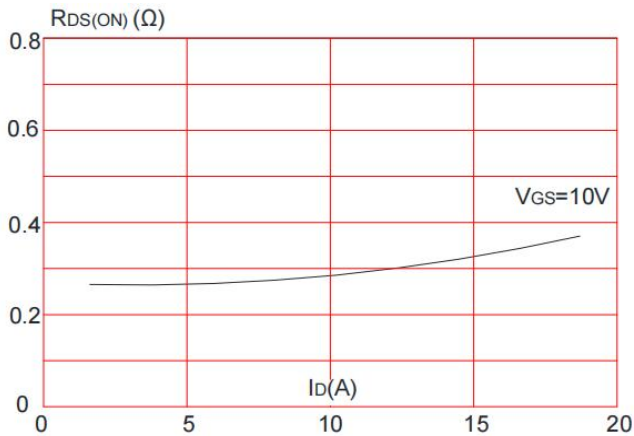


Figure 4: Body Diode Characteristics

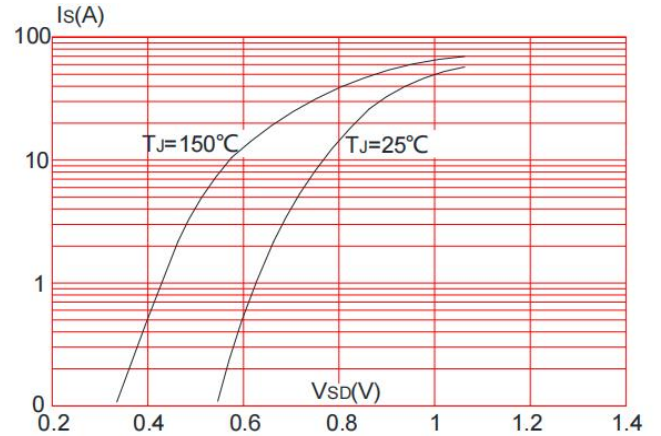


Figure 5: Gate Charge Characteristics

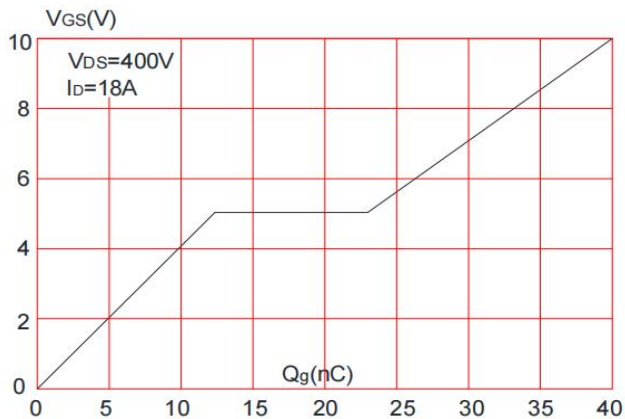
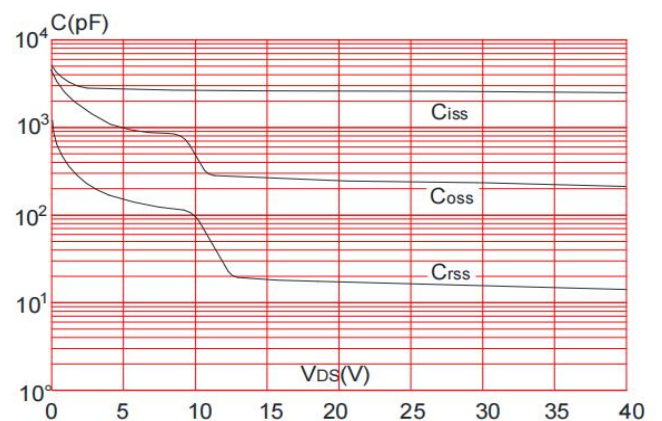


Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

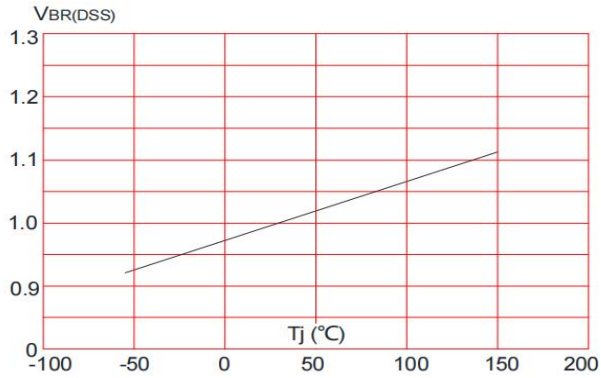


Figure 8: Normalized on Resistance vs. Junction Temperature

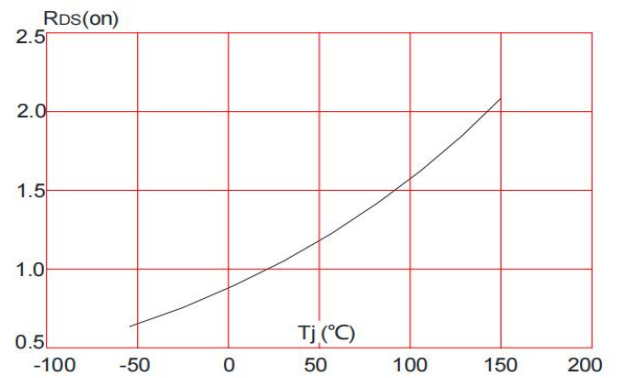


Figure 9: Maximum Safe Operating Area

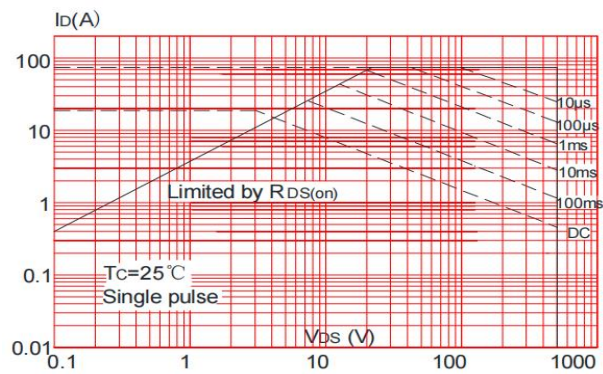


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

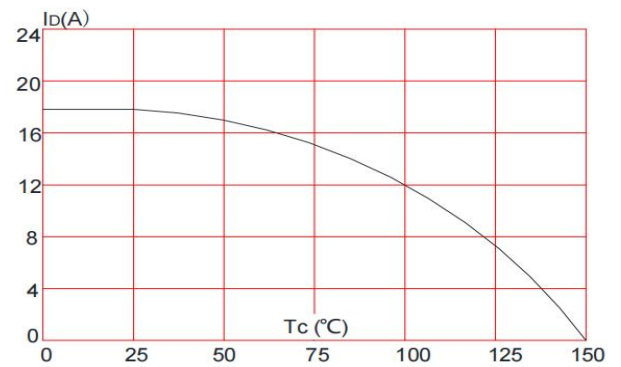
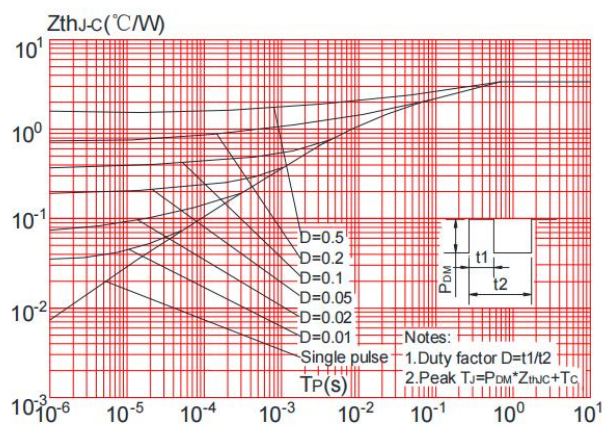


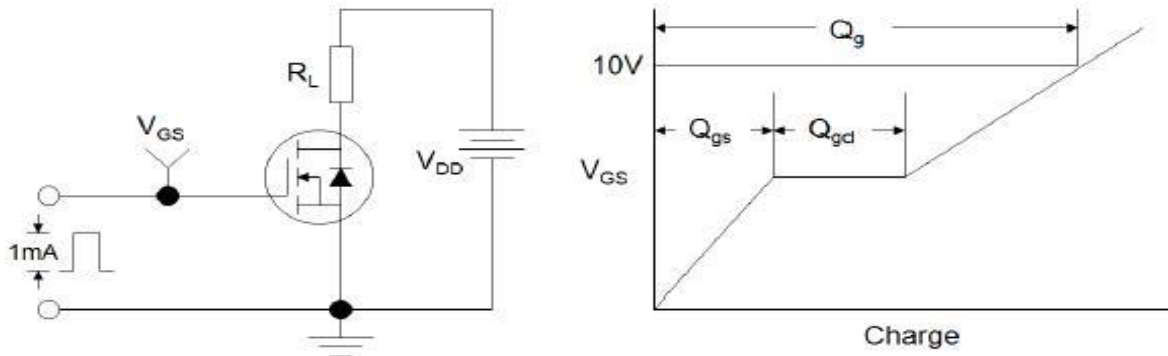
Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



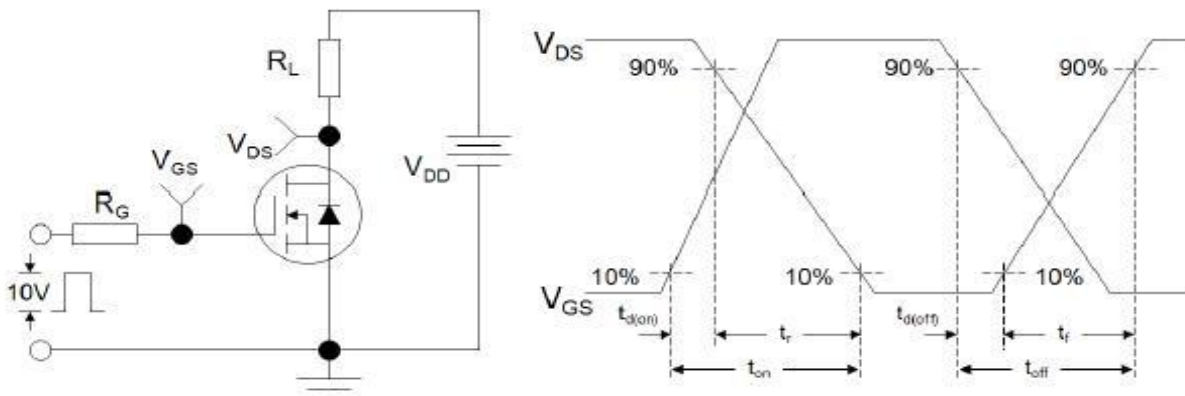
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Test Circuit & Waveform

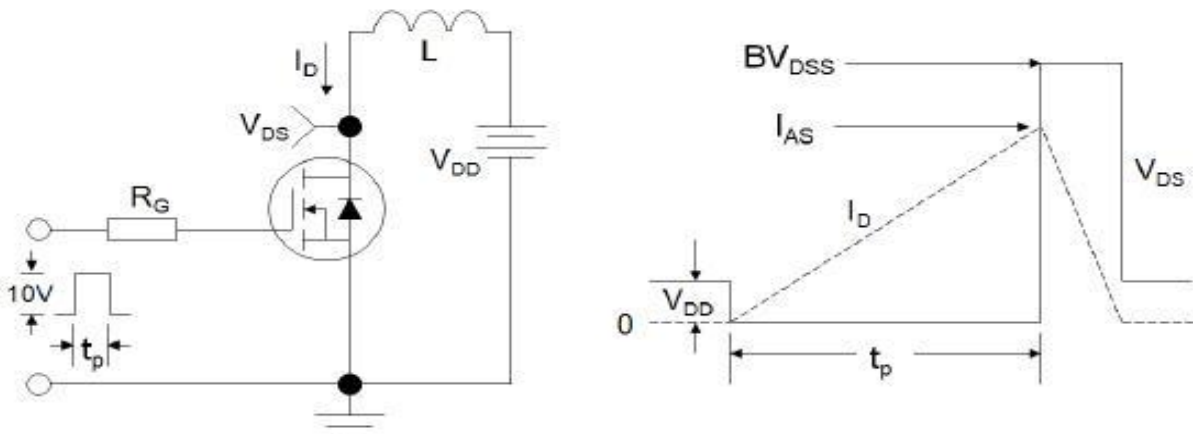
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



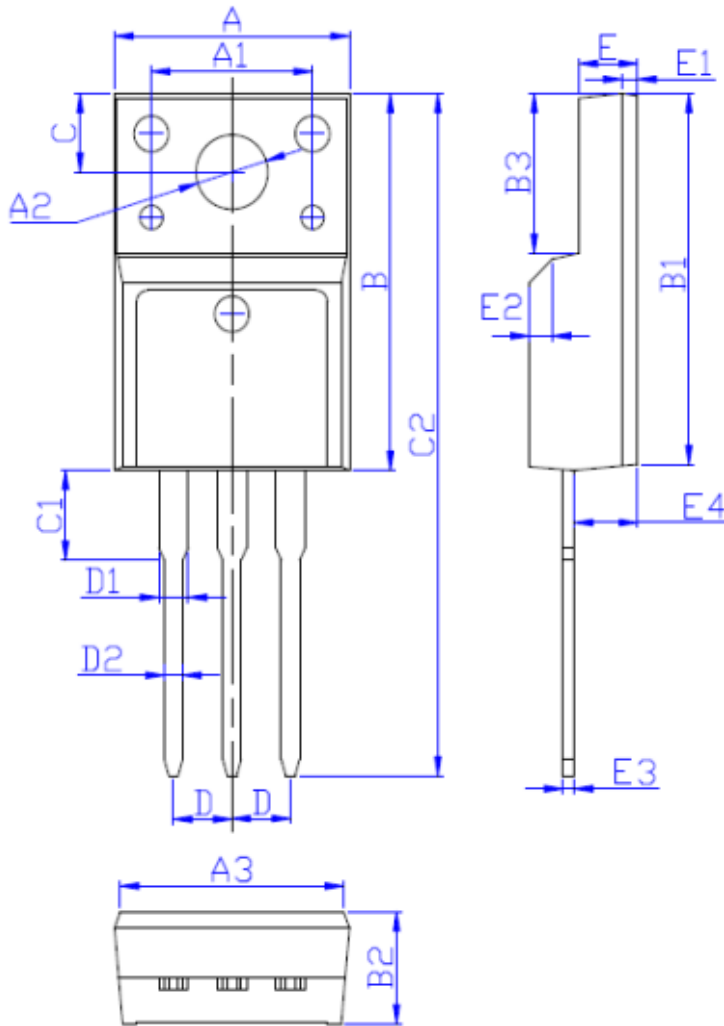
Unclamped Inductive Switching (UIS) Test Circuit & Waveform



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Package Dimension:

TO-220F



DIM	MILLIMETERS
A	10.16 ± 0.30
A1	7.00 ± 0.20
A2	3.12 ± 0.20
A3	9.70 ± 0.30
B	15.90 ± 0.50
B1	15.60 ± 0.50
B2	4.70 ± 0.30
B3	6.70 ± 0.30
C	3.30 ± 0.25
C1	3.25 ± 0.30
C2	28.70 ± 0.50
D	Typical 2.54
D1	1.47 (MAX)
D2	0.80 ± 0.20
E	2.55 ± 0.25
E1	0.70 ± 0.25
E2	$1.0 \times 45^\circ$
E3	0.50 ± 0.20
E4	2.75 ± 0.30

(Unit: mm)